

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10042904	LIN ET AL.
	<b>Examiner</b> Turk, Neil	<b>Art Unit</b> 1797

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
73 and text, EAST; *see attached history	11/20/2007	NT
422 and text, EAST; *see attached history	11/20/07	NT
422/87 and text, EAST; *see attached history	11/20/07	NT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>